

## BYV27 series

### FEATURES

- Glass passivated
- High maximum operating temperature
- Low leakage current
- Excellent stability
- Guaranteed avalanche energy absorption capability
- Available in ammo-pack.

### DESCRIPTION

Rugged glass SOD57 package, using a high temperature alloyed construction.

This package is hermetically sealed and fatigue free as coefficients of expansion of all used parts are matched.

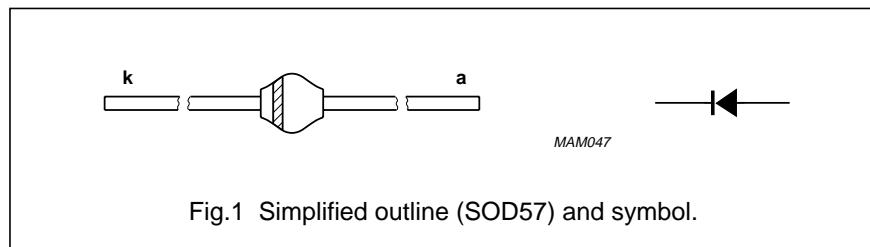


Fig.1 Simplified outline (SOD57) and symbol.

### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{RRM}$	repetitive peak reverse voltage BYV27-50 BYV27-100 BYV27-150 BYV27-200 BYV27-300 BYV27-400 BYV27-500 BYV27-600		–	50	V
$V_R$	continuous reverse voltage BYV27-50 BYV27-100 BYV27-150 BYV27-200 BYV27-300 BYV27-400 BYV27-500 BYV27-600		–	50	V
$I_{F(AV)}$	average forward current BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$T_{tp} = 85^\circ\text{C}$ ; lead length = 10 mm; see Figs 2, 3 and 4; averaged over any 20 ms period; see also Figs 14, 15 and 16	–	2.0	A
$I_{F(AV)}$	average forward current BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$T_{amb} = 60^\circ\text{C}$ ; printed-circuit board mounting (see Fig. 25); see Figs 5, 6 and 7; averaged over any 20 ms period; see also Figs 14, 15 and 16	–	1.30	A
			–	1.25	A
			–	1.10	A



## SCHOTTKY BARRIER RECTIFIER

### BYV27 series

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$I_{FRM}$	repetitive peak forward current BYV27-50 to 400 BYV27-500 and 600	$T_{tp} = 85^\circ\text{C}$ ; see Figs 8, 9 and 10	–	20	A
			–	16	A
$I_{FRM}$	repetitive peak forward current BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$T_{amb} = 60^\circ\text{C}$ ; see Figs 11, 12 and 13	–	14	A
			–	13	A
			–	11	A
$I_{FSM}$	non-repetitive peak forward current BYV27-50 to 400 BYV27-500 and 600	$t = 10 \text{ ms half sine wave}$ ; $T_j = T_{j \max}$ prior to surge; $V_R = V_{RRM\max}$	–	50	A
			–	40	A
$E_{RSM}$	non-repetitive peak reverse avalanche energy	$L = 120 \text{ mH}$ ; $T_j = T_{j \max}$ prior to surge; inductive load switched off	–	20	mJ
$T_{stg}$	storage temperature		–65	+175	°C
$T_j$	junction temperature	see Fig. 17	–65	+175	°C

### ELECTRICAL CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_F$	forward voltage BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$I_F = 2 \text{ A}$ ; $T_j = T_{j \max}$ ; see Figs 18, 19 and 20	–	–	0.78	V
			–	–	0.82	V
			–	–	1.00	V
$V_F$	forward voltage BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$I_F = 2 \text{ A}$ ; see Figs 18, 19 and 20	–	–	0.98	V
			–	–	1.05	V
			–	–	1.25	V
$V_{(BR)R}$	reverse avalanche breakdown voltage BYV27-50 BYV27-100 BYV27-150 BYV27-200 BYV27-300 BYV27-400 BYV27-500 BYV27-600	$I_R = 0.1 \text{ mA}$	55	–	–	V
			110	–	–	V
			165	–	–	V
			220	–	–	V
			330	–	–	V
			440	–	–	V
			560	–	–	V
			675	–	–	V
$I_R$	reverse current	$V_R = V_{RRM\max}$ ; see Fig. 21	–	–	5	μA
		$V_R = V_{RRM\max}$ ; $T_j = 165^\circ\text{C}$ ; see Fig. 21	–	–	150	μA

## BYV27 series

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$t_{rr}$	reverse recovery time BYV27-50 to 200 BYV27-300 to 600	when switched from $I_F = 0.5 \text{ A}$ to $I_R = 1 \text{ A}$ ; measured at $I_R = 0.25 \text{ A}$ ; see Fig. 27	—	—	25 50	ns ns
$C_d$	diode capacitance BYV27-50 to 200 BYV27-300 and 400 BYV27-500 and 600	$f = 1 \text{ MHz}$ ; $V_R = 0$ ; see Figs 22, 23 and 24	— — —	100 80 65	— — —	pF pF pF
$\left  \frac{dI_R}{dt} \right $	maximum slope of reverse recovery current	when switched from $I_F = 1 \text{ A}$ to $V_R \geq 30 \text{ V}$ and $dI_F/dt = -1 \text{ A}/\mu\text{s}$ ; see Fig. 26	—	—	4	A/ $\mu\text{s}$

### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th j\text{-tp}}$	thermal resistance from junction to tie-point	lead length = 10 mm	46	K/W
$R_{th j\text{-a}}$	thermal resistance from junction to ambient	note 1	100	K/W

#### Note

1. Device mounted on an epoxy-glass printed-circuit board, 1.5 mm thick; thickness of Cu-layer  $\geq 40 \mu\text{m}$ , see Fig. 25.  
For more information please refer to the "General Part of associated Handbook".

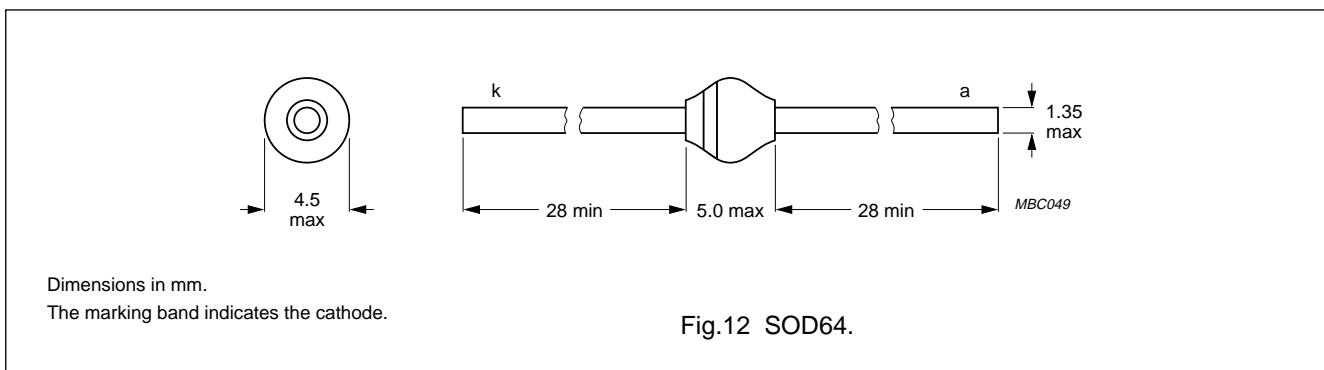
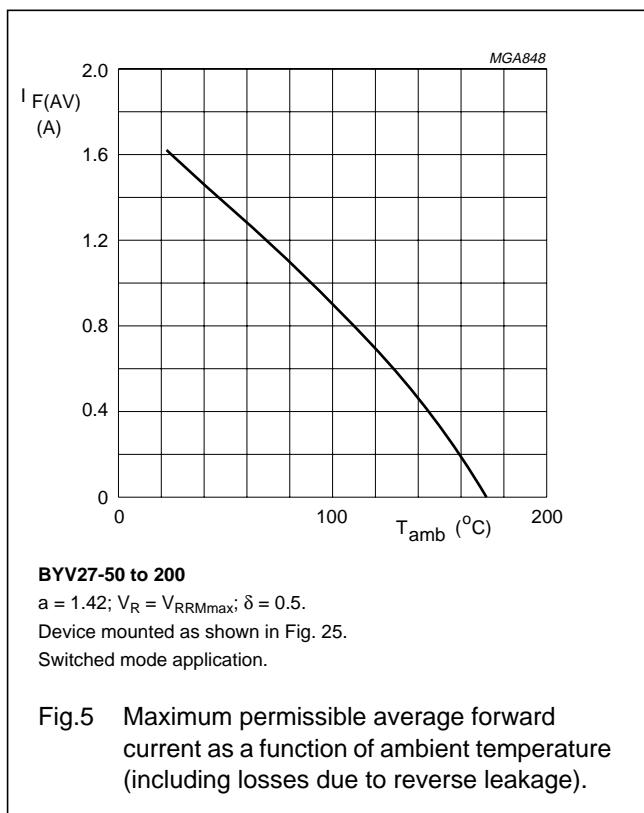
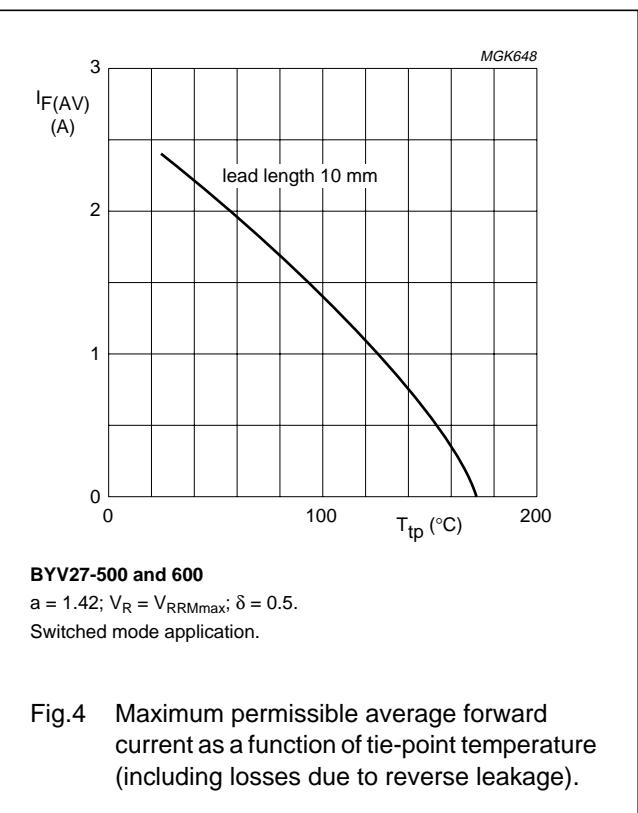
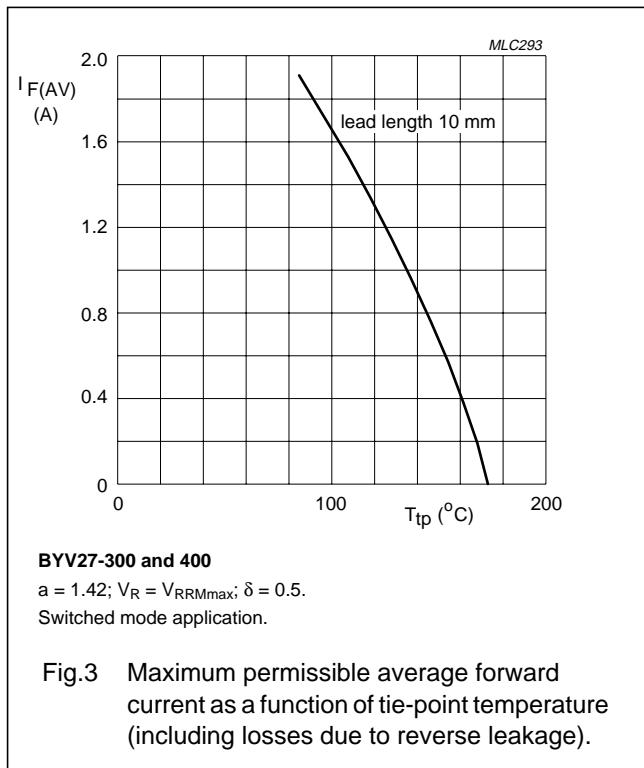
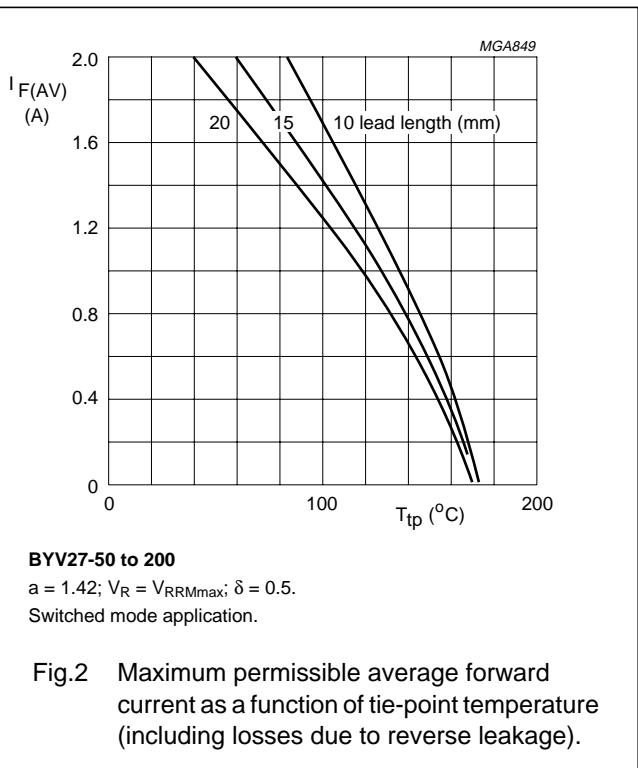


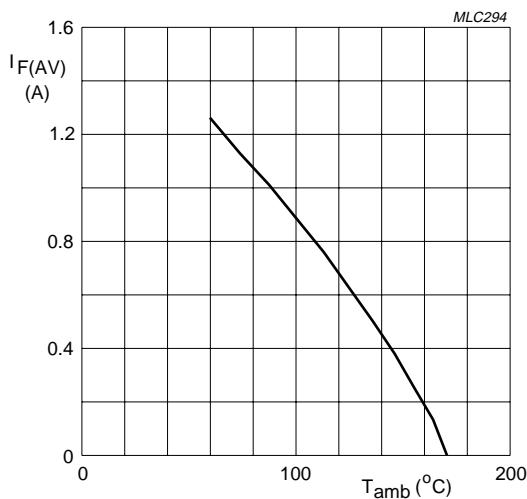
Fig.12 SOD64.

## BYV27 series

### GRAPHICAL DATA



## BYV27 series

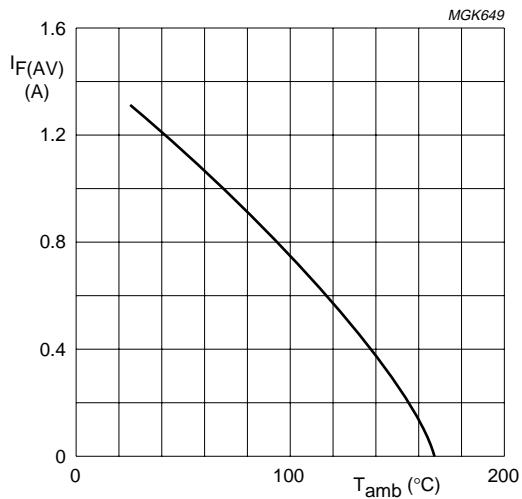

**BYV27-300 and 400**

a = 1.42; V<sub>R</sub> = V<sub>RRMmax</sub>; δ = 0.5.

Device mounted as shown in Fig. 25.

Switched mode application.

Fig.6 Maximum permissible average forward current as a function of ambient temperature (including losses due to reverse leakage).

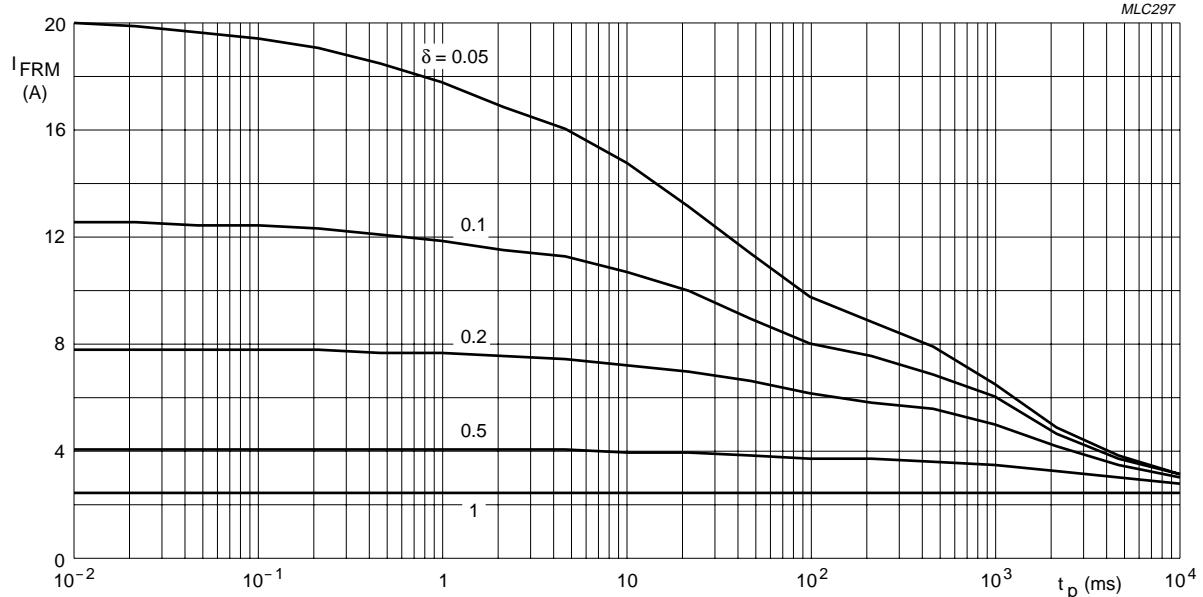

**BYV27-500 and 600**

a = 1.42; V<sub>R</sub> = V<sub>RRMmax</sub>; δ = 0.5.

Device mounted as shown in Fig. 25.

Switched mode application.

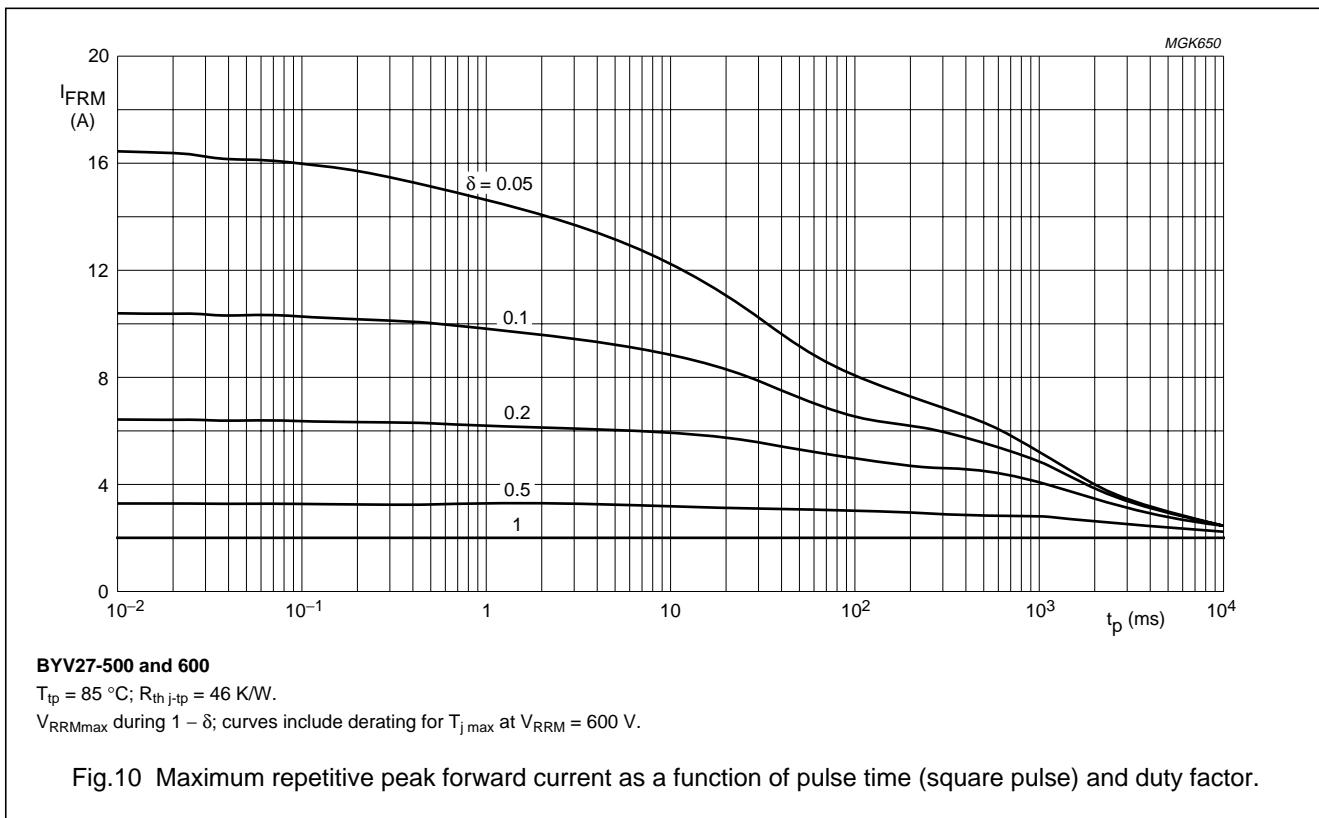
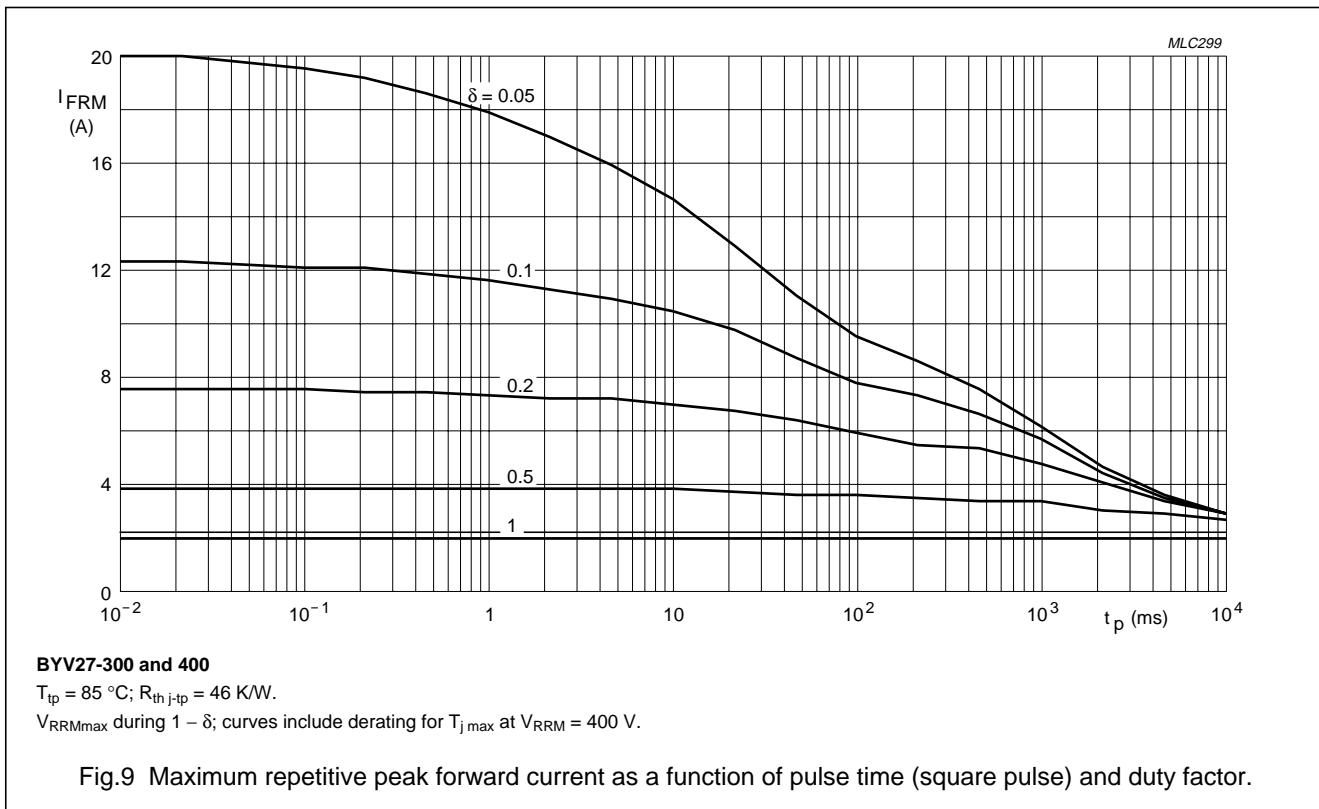
Fig.7 Maximum permissible average forward current as a function of ambient temperature (including losses due to reverse leakage).

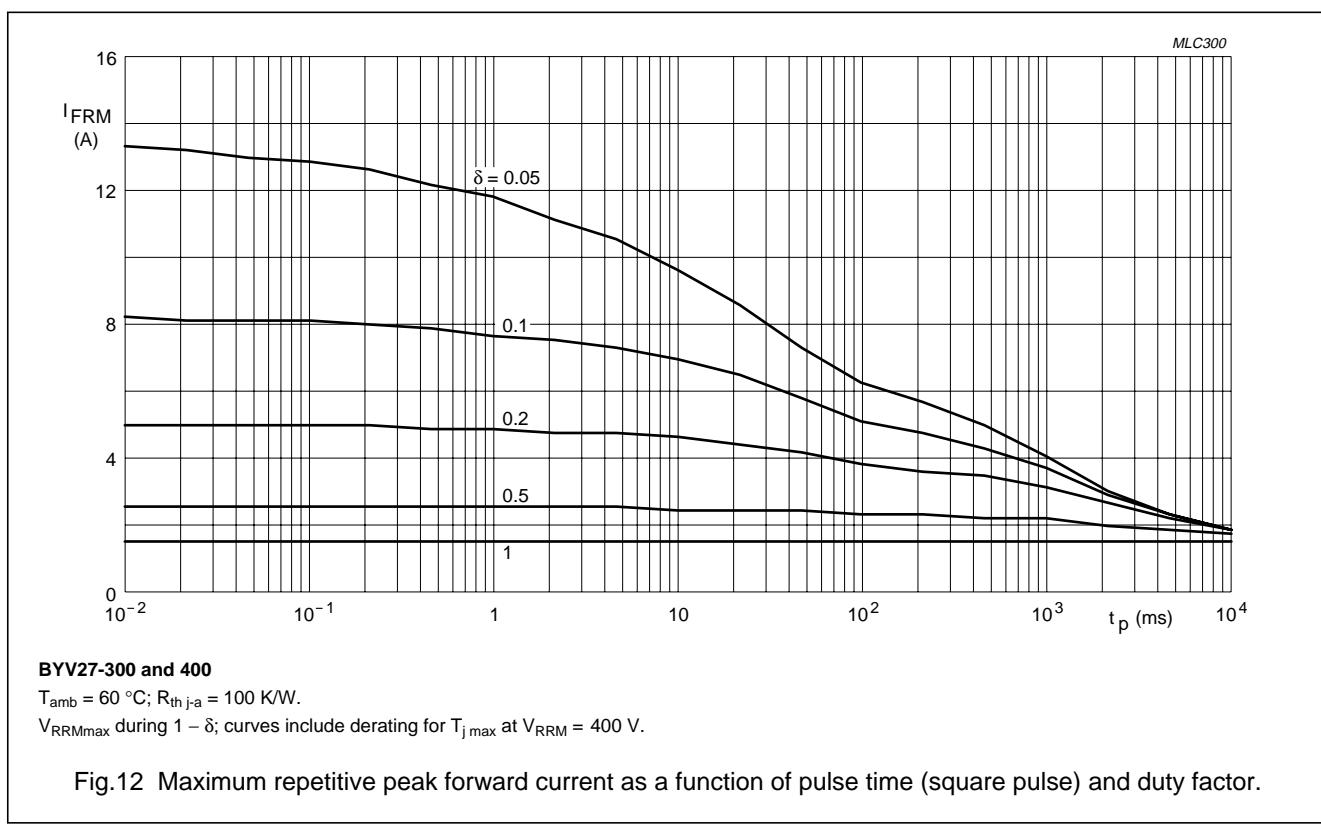
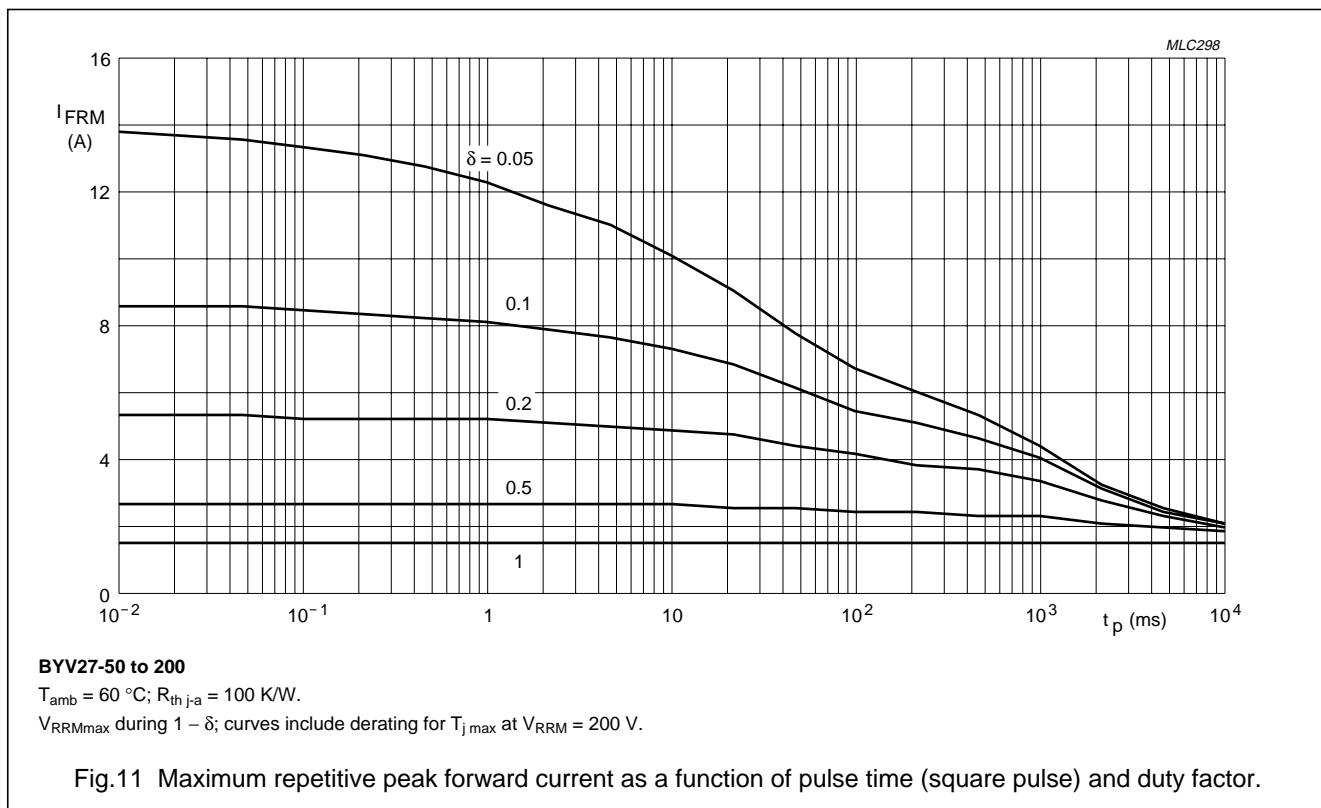

**BYV27-50 to 200**

T<sub>tp</sub> = 85 °C; R<sub>th j-tp</sub> = 46 K/W.

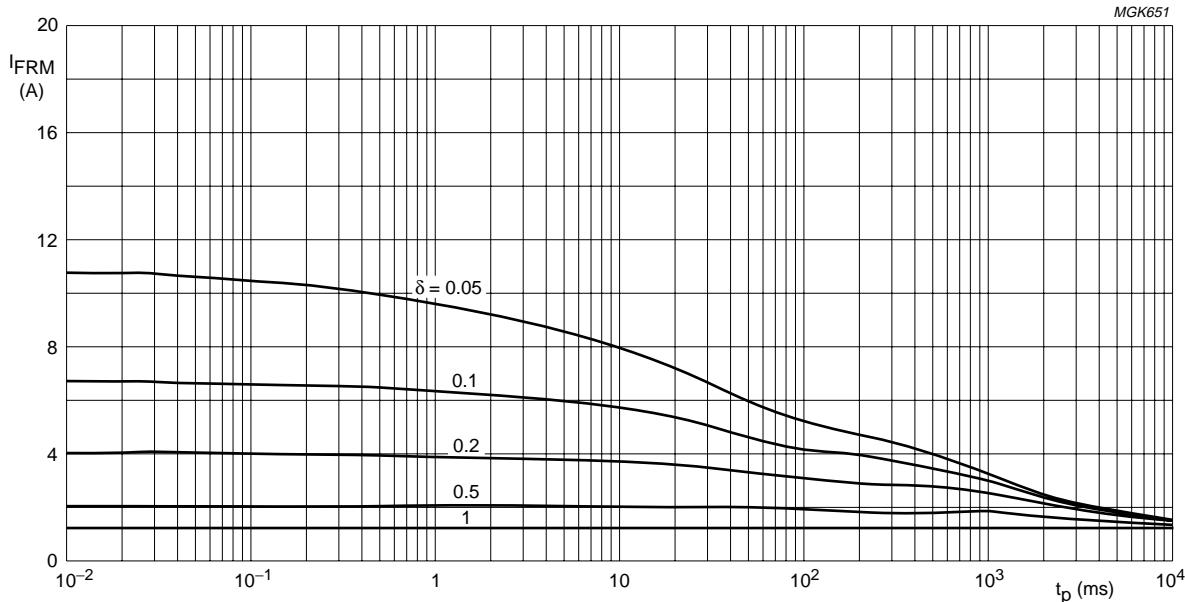
V<sub>RRMmax</sub> during 1 - δ; curves include derating for T<sub>j max</sub> at V<sub>RRM</sub> = 200 V.

Fig.8 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.

**BYV27 series**


**BYV27 series**


## BYV27 series


**BYV27-500 and 600**
 $T_{amb} = 60 \text{ } ^\circ\text{C}; R_{th\ j-a} = 100 \text{ K/W}$ .

 $V_{RRMmax}$  during  $1 - \delta$ ; curves include derating for  $T_{j\ max}$  at  $V_{RRM} = 600 \text{ V}$ .

Fig.13 Maximum repetitive peak forward current as a function of pulse time (square pulse) and duty factor.

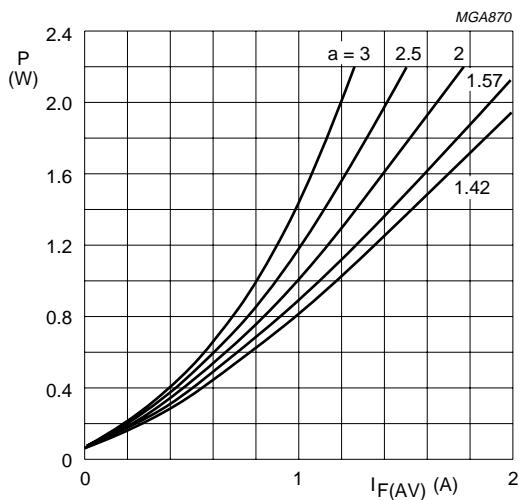

**BYV27-50 to 200**
 $a = I_{F(RMS)} / I_{F(AV)}; V_R = V_{RRMmax}; \delta = 0.5$ .

Fig.14 Maximum steady state power dissipation (forward plus leakage current losses, excluding switching losses) as a function of average forward current.

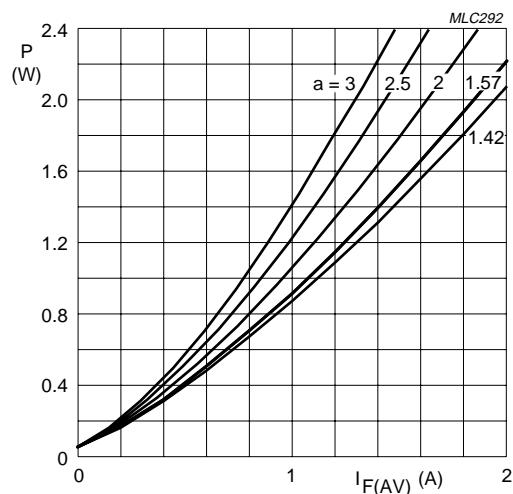

**BYV27-300 and 400**
 $a = I_{F(RMS)} / I_{F(AV)}; V_R = V_{RRMmax}; \delta = 0.5$ .

Fig.15 Maximum steady state power dissipation (forward plus leakage current losses, excluding switching losses) as a function of average forward current.

## BYV27 series

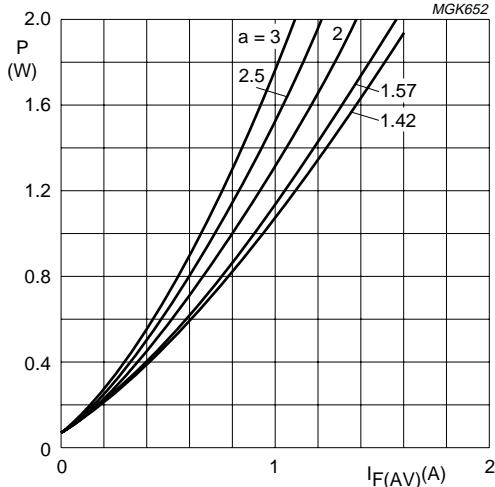
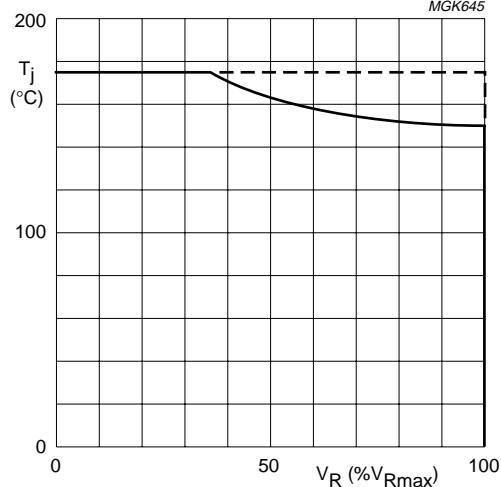
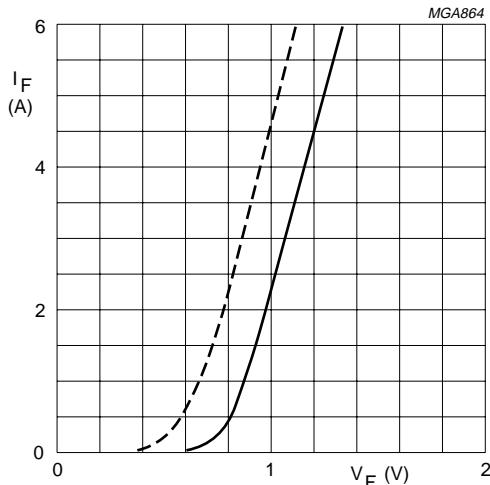

**BYV27-500 and 600**
 $a = I_{F(RMS)} / I_{F(AV)}$ ;  $V_R = V_{RRMmax}$ ;  $\delta = 0.5$ .

Fig.16 Maximum steady state power dissipation (forward plus leakage current losses, excluding switching losses) as a function of average forward current.


Solid line =  $V_R$ .

Dotted line =  $V_{RRM}$ ;  $\delta = 0.5$ .

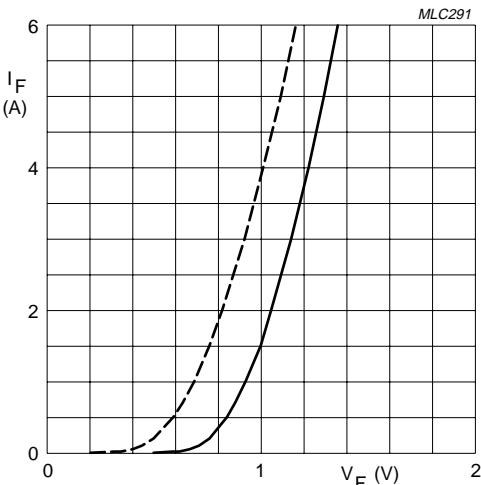
Fig.17 Maximum permissible junction temperature as a function of maximum reverse voltage percentage.


**BYV27-50 to 200**

Dotted line:  $T_j = 175$  °C.

Solid line:  $T_j = 25$  °C.

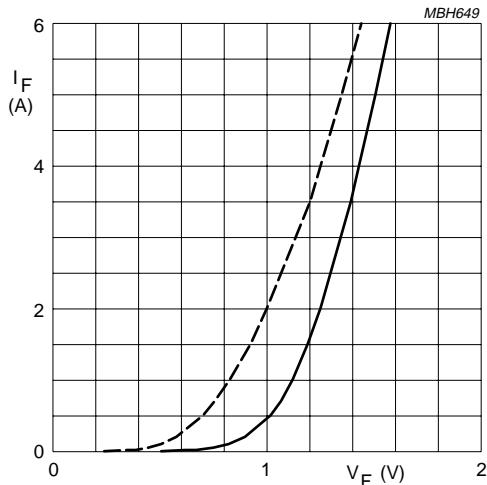
Fig.18 Forward current as a function of forward voltage; maximum values.


**BYV27-300 and 400**

Dotted line:  $T_j = 175$  °C.

Solid line:  $T_j = 25$  °C.

Fig.19 Forward current as a function of forward voltage; maximum values.

**BYV27 series**

**BYV27-500 and 600**

Dotted line:  $T_j = 175 \text{ }^\circ\text{C}$ .  
 Solid line:  $T_j = 25 \text{ }^\circ\text{C}$ .

Fig.20 Forward current as a function of forward voltage; maximum values.

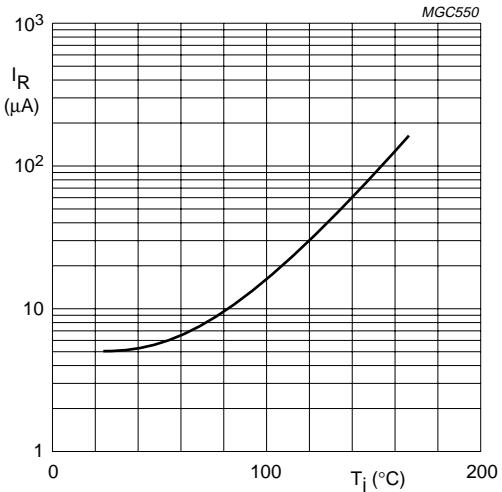
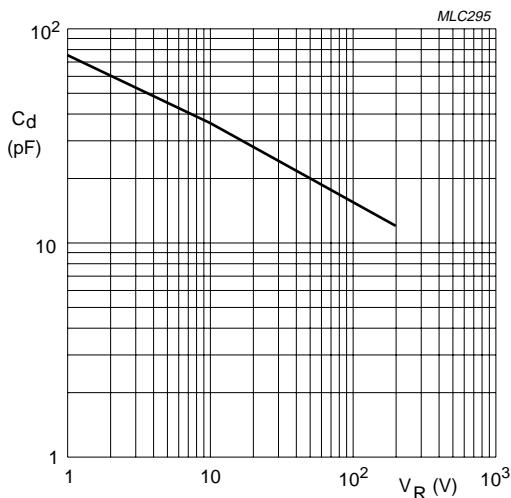
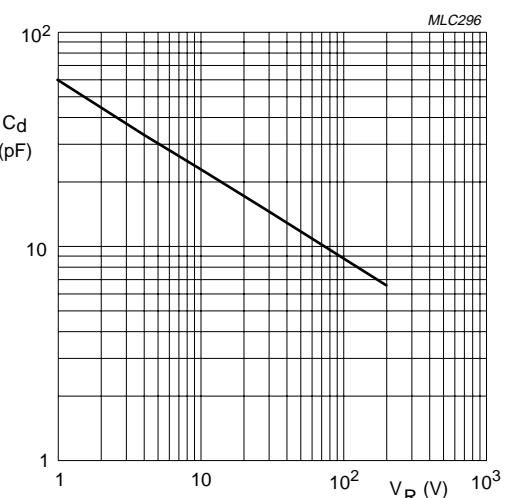

 $V_R = V_{RRMmax}$ .

Fig.21 Reverse current as a function of junction temperature; maximum values.


**BYV27-50 to 200**

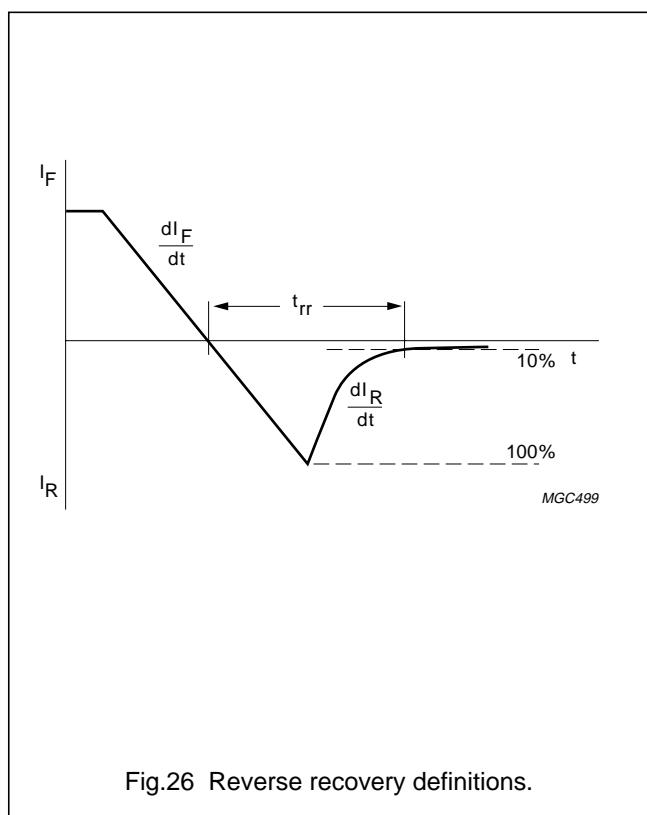
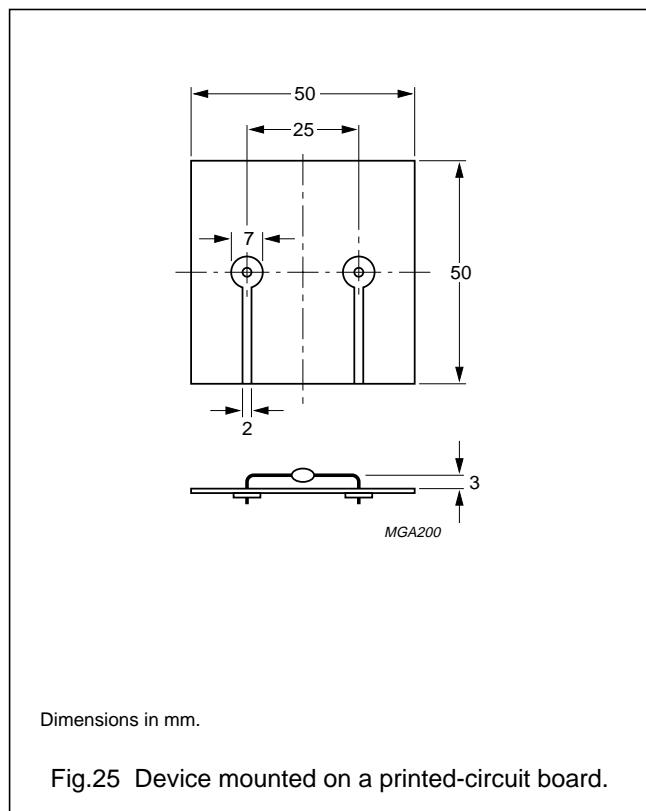
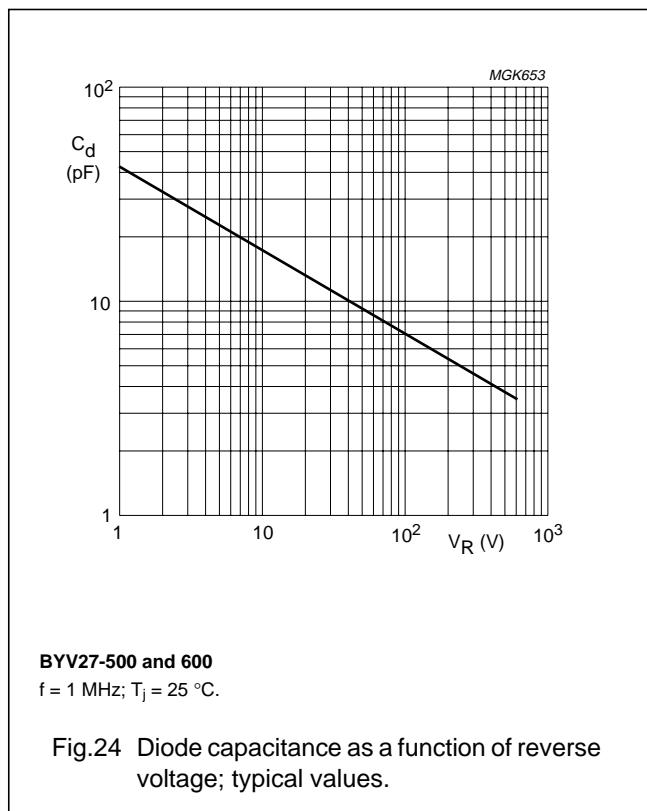
f = 1 MHz;  $T_j = 25 \text{ }^\circ\text{C}$ .

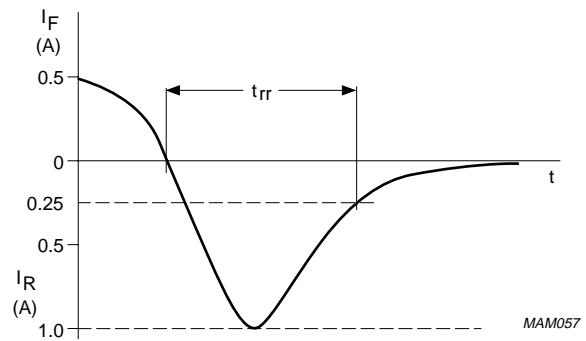
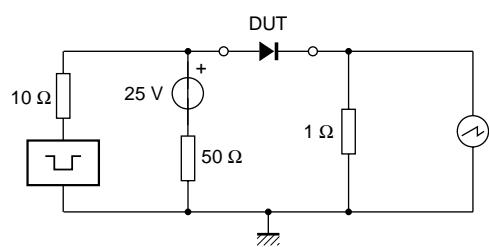
Fig.22 Diode capacitance as a function of reverse voltage; typical values.


**BYV27-300 and 400**

f = 1 MHz;  $T_j = 25 \text{ }^\circ\text{C}$ .

Fig.23 Diode capacitance as a function of reverse voltage; typical values.

**BYV27 series**


**BYV27 series**


Input impedance oscilloscope:  $1 \text{ M}\Omega$ ,  $22 \text{ pF}$ ;  $t_r \leq 7 \text{ ns}$ .

Source impedance:  $50 \Omega$ ;  $t_r \leq 15 \text{ ns}$ .

Fig.27 Test circuit and reverse recovery time waveform and definition.